

CONTROLLER SIMULATED SURGE ARRESTER OPERATION TEST REPORT

Client:	Schweitzer Engineering Laboratories, 2350 NE Hopkins Court, Pullman, WA 99163-5603, USA		
Test Date:	15 & 16 May 2006	Project:	16533-27
Nameplate Data:			
Controller:			
Manufacturer:	Schweitzer Engineering Laboratories, Pullman, Washington, USA		
Model:	SEL-651R		
Part No.:	0651R043AAX203X1XX		
Serial No.:	2006088297		
Recloser:			
Manufacturer:	Cooper Power Systems, Milwaukee, WI, USA		
Type:	NOVA27		
Impulse level (BIL):	125 kV _{peak}		
Rated voltage:	27 kV _{rms}		
Rated current:	630 A _{rms} continuous; 12.5 kA interrupting		
Serial No.:	A-002179		
Test Witness:	Darin McKee, Schweitzer Engineering Laboratories		
Test Standard:	IEEE Std C37.60-2003, Clause 6.13.2: "Simulated Surge Arrester Operation Test"		
Atmospheric Conditions:	Temperature	23.6°C	
	Relative humidity	36.7%	
	Barometric pressure	760.5 mmHg	
Test Current:	7 kA _{peak}		
Test Configurations (in accordance with the above standard):			
<p>A – surges applied to the source bushing with the recloser open B – surges applied to the source bushing with the recloser closed C – surges applied to the load bushing with the recloser closed D – surges applied to a properly rated transformer with the recloser open E – surges applied to a properly rated transformer with the recloser closed</p> <p>If the device under test has a self-contained power source, conditions D and E may be omitted. This controller is designed to be powered by isolated dc batteries, so configuration D and E were omitted.</p>			
Test Results:	The controller and recloser operated normally following the Simulated Surge Arrester Operation Test performed in accordance with the test procedures as per the above standard. The controller complied with the requirements of IEEE Std C37.60-2003, Clause 6.13.2.		
Remarks:	None		

Prepared by:



May Wang, P.Eng. *May 26, 2006*
Senior Electrical Engineer

Approved by:



A.J. Vandermaar, P.Eng. *26 May 2006*
Manager, High Voltage Laboratory


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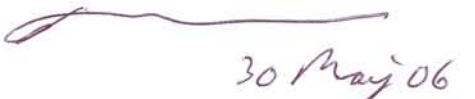
CONTROLLER OSCILLATORY SWC TEST REPORT

Client:	Schweitzer Engineering Laboratories, 2350 NE Hopkins Court, Pullman, WA 99163-5603, USA	
Test Date:	May 16, 2006	Project: 16533-27
Nameplate Data:		
Controller:		
Manufacturer:	Schweitzer Engineering Laboratories, Pullman, Washington, USA	
Model:	SEL-651R	
Part No.:	0651R043AAX203X1XX	
Serial No.:	2006088297	
Recloser:		
Manufacturer:	Cooper Power Systems, Milwaukee, WI, USA	
Type:	NOVA27	
Impulse level (BIL):	125 kV _{peak}	
Rated voltage:	27 kV _{rms}	
Rated current:	630 A _{rms} continuous; 12.5 kA interrupting	
Serial No.:	A-002179	
Test Witness:	Darin McKee, Schweitzer Engineering Laboratories	
Test Standard:	IEEE Std C37.60-2003, Clause 6.13.1: "Oscillatory and fast transients surge tests"	
Test Voltage:	2.5 kV _{peak}	
Test Procedure:	Test surge applied in common mode and transverse mode to wire pairs.	
Test Results:	The controller and recloser operated normally following the Oscillatory SWC Test performed in accordance with the test procedures. The controller complied with requirements of IEEE C37.60-2003, Clause 6.13.1.	
Remarks:	The controller passed the test.	

Tested by:

Approved by:


Robert G. Pollock
Senior Project Specialist


30 May 06
A. John Vandermaar, P.Eng.
Manager, High Voltage Laboratory

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APPENDIX 1

Oscillatory SWC Waveform Validity Tests

(in accordance with IEEE Std C37.90.1-2002, Clause A.2)

Performed before the Oscillatory SWC Test

1. Measuring system feedthrough test

Generator Output voltage 2.5 kVFeedthrough voltage 3 V (pass $\leq 1\%$)

2. Open circuit voltage waveform test

Recorded waveforms – Figures 1 and 2.

3. Test Generator performance verification

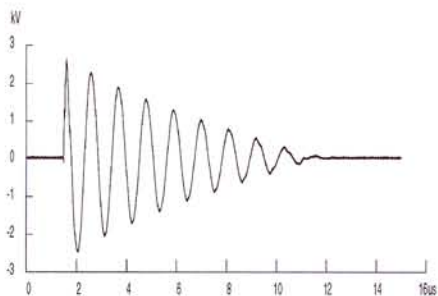
Rise time of the first peak 72 ns (60 to 90 ns – 10% to 90%)Peak voltage level (no load) 2.5 kV (2.25 to 2.5 kV when set to 2.5 kV)Output impedance 191 Ω (160 to 240 Ω)Waveform envelope decay 4.92 μ s (4 to 6 μ s to 50%)Oscillation frequency 0.91 MHz (0.9 to 1.1 MHz)Repetition rate 8 bursts per period (6-10 bursts per 16.7 mS)Test duration 2.1 s (2 to 2.2 s)4. Test Pass X Test Fail _____

Figure 1

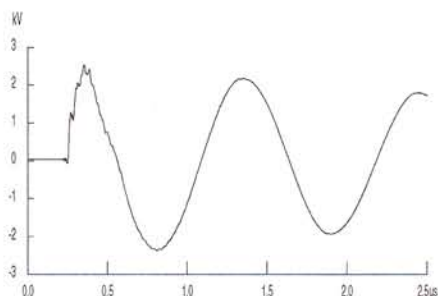


Figure 2

APPENDIX 2

Oscillatory SWC Waveform Validity Tests
(in accordance with IEEE Std C37.90.1-2002, Clause A.2)

Performed after the Oscillatory SWC Test

4. Measuring system feedthrough test

Generator Output voltage 2.5 kV
 Feedthrough voltage 4.1 V (pass ≤ 1%)

5. Open circuit voltage waveform test

Recorded waveforms – Figures 1 and 2.

6. Test Generator performance verification

Rise time of the first peak	<u>86</u> ns	(60 to 90 ns – 10% to 90%)
Peak voltage level (no load)	<u>2.3</u> kV	(2.25 to 2.5 kV when set to 2.5 kV)
Output impedance	<u>232</u> Ω	(160 to 240 Ω)
Waveform envelope decay	<u>4.4</u> μs	(4 to 6 μs to 50%)
Oscillation frequency	<u>0.93</u> MHz	(0.9 to 1.1 MHz)
Repetition rate	<u>8</u> bursts per period	(6-10 bursts per 16.7 mS)
Test duration	<u>2.17</u> s	(2 to 2.2 s)

5. Test Pass X Test Fail _____

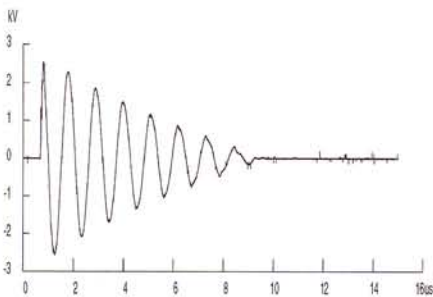


Figure 1

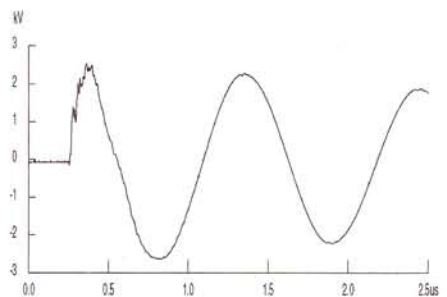


Figure 2

CONTROLLER FAST TRANSIENT SWC TEST REPORT

Client:	Schweitzer Engineering Laboratories, 2350 NE Hopkins Court, Pullman, WA 99163-5603, USA	
Test Date:	May 16, 2006	Project: 16533-27
Nameplate Data:		
Controller:		
Manufacturer:	Schweitzer Engineering Laboratories, Pullman, Washington, USA	
Model:	SEL-651R	
Part No.:	0651R043AAX203X1XX	
Serial No.:	2006088297	
Recloser:		
Manufacturer:	Cooper Power Systems, Milwaukee, WI, USA	
Type:	NOVA27	
Impulse level (BIL):	125 kV _{peak}	
Rated voltage:	27 kV _{rms}	
Rated current:	630 A _{rms} continuous; 12.5 kA interrupting	
Serial No.:	A-002179	
Test Witness:	Darin McKee, Schweitzer Engineering Laboratories	
Test Standard:	IEEE Std C37.60-2003, Clause 6.13.1: "Oscillatory and fast transients surge tests"	
Test Voltage:	4.0 kV _{peak}	
Test Procedure:	Test surge applied in common mode and transverse mode to wire pairs.	
Test Results:	The controller and recloser operated normally following the Fast Transient SWC Test performed in accordance with the test procedures. The controller complied with the requirements of IEEE C37.60-2003, Clause 6.13.1.	
Remarks:	The controller passed the test.	

Tested by:

Approved by:



Robert G. Pollock
 Senior Project Specialist



A. John Vandermaar, P.Eng.
 Manager, High Voltage Laboratory

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APPENDIX 1

Fast Transient SWC Waveform Validity Tests

(in accordance with IEEE Std C37.90.1-2002, Clause A.2)

Performed before the Fast Transient SWC Test

1. Measuring system feedthrough test

Generator Output voltage 4 kVFeedthrough voltage 0 V (pass if $\leq 1\%$)

2. Open circuit voltage waveform test

Recorded waveforms – Figures 1 and 2.

3. Test Generator performance verification

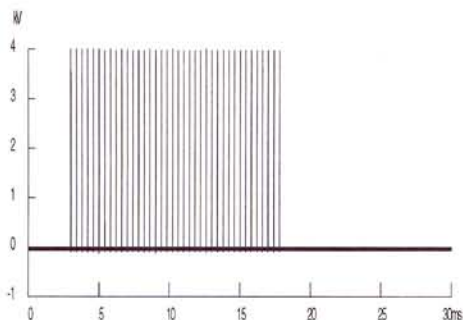
Rise time 3.85 ns (3.5 to 6.5 ns – 10% to 90%)Peak voltage level (no load) 4.0 kV (3.6 to 4.4 kV when set to 4 kV)Output impedance 47.9 Ω (40 to 60 Ω)Impulse duration 60.2 ns (35 to 65 ns to 50% value)Repetition rate 2.5 kHz (2 to 3 kHz)Burst duration 15.0 ms (12 to 18 ms)Burst period 300 ms (240 to 360 ms)Test duration 60.0 s (≥ 60 s)4. Test Pass X Test Fail _____

Figure 1

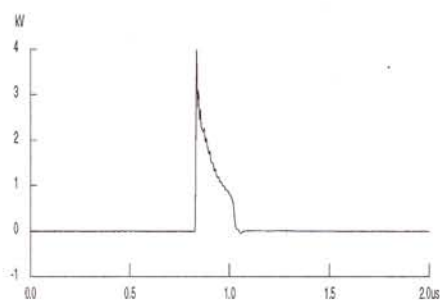


Figure 2

APPENDIX 2

Fast Transient SWC Waveform Validity Tests
 (in accordance with IEEE Std C37.90.1-2002, Clause A.2)

Performed after the Fast Transient SWC Test

5. Measuring system feedthrough test

Generator Output voltage 4 kV
 Feedthrough voltage 0 V (pass if $\leq 1\%$)

6. Open circuit voltage waveform test

Recorded waveforms – Figures 1 and 2.

7. Test Generator performance verification

Rise time	<u>3.5</u> ns	(3.5 to 6.5 ns – 10% to 90%)
Peak voltage level (no load)	<u>4.2</u> kV	(3.6 to 4.4 kV when set to 4 kV)
Output impedance	<u>49.8</u> Ω	(40 to 60 Ω)
Impulse duration	<u>63</u> ns	(35 to 65 ns to 50% value)
Repetition rate	<u>2.5</u> kHz	(2 to 3 kHz)
Burst duration	<u>15.0</u> ms	(12 to 18 ms)
Burst period	<u>300</u> ms	(240 to 360 ms)
Test duration	<u>60.4</u> s	(≥ 60 s)

8. Test Pass X Test Fail _____

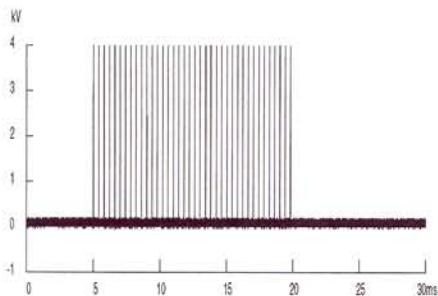


Figure 1

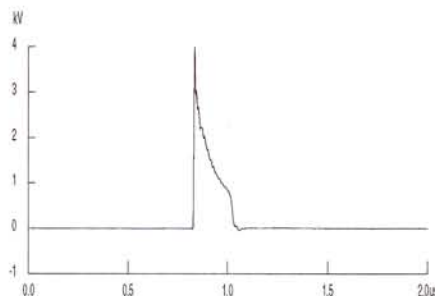


Figure 2